



**Model: ST4000NM0033-9ZM**

**S/N: S1Z1XEV**



## Disk Erasure Report

Page 1 - Erasure Status

### Organisation Performing The Disk Erasure

Business Name: **GridJet**

Business Address:

Contact Name: **GDW-LDS-3**

Contact Phone:

### Customer Details

Name: **Gridjet**

Address:

Contact Name:

Contact Phone:

### Disk Information

Make/Model: **ST4000NM0033-9ZM**

Serial: **S1Z1XEV**

Size(Apparent): **4000 GB, 4000787030016 bytes**

Bus: **ATA**

Size(Real): **4000 GB, 4000787030016 bytes**

### Disk Erasure Details

Start time: **2026/01/21 15:58:52**

End time: **2026/01/22 17:45:52**

Duration: **25:47:00**

Status: **ERASED**

Method: **PRNG Stream**

PRNG algorithm: **XORshiro256**

Final Pass(Zeros/Ones/None): **Zeros**

Verify Pass(Last/All/None): **Verify Last**

\*Bytes Erased: **4000787030016, (100.00%)**

Rounds(completed/requested): **1/1**

HPA/DCO: **No hidden sectors**

HPA/DCO Size: **No hidden sectors**

Errors(pass/sync/verify): **0/0/0**

Throughput: **129 MB/sec**

Information:

**\* bytes erased: The amount of drive that's been erased at least once**

Technician/Operator ID

Signature:

Name/ID: **Auto Wipe**



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## Disk Erasure Report

Page 2 - Smart Data

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```
smartctl 7.2 2020-12-30 r5155 [x86_64-linux-5.14.0-503.23.1.el9_5.x86_64] (local build)
copyright (c) 2002-20, bruce allen, christian franke, www.smartmontools.org
```

```
==== start of information section ===
model family:      Seagate Constellation ES.3
device model:     ST4000NM0033-9ZM170
serial number:    S1Z1XEV
lu wwn device id: 5 000c50 08cbe087
add. product id:  DELL(tm)
firmware version: GA6E
user capacity:   4,000,787,030,016 bytes [4.00 TB]
sector size:     512 bytes logical/physical
rotation rate:   7200 rpm
form factor:    3.5 inches
device is:       In smartctl database [for details use: -P show]
ata version is:  ACS-2 (minor revision not indicated)
sata version is: SATA 3.0, 6.0 Gb/s (current: 6.0 Gb/s)
local time is:   Thu Jan 22 17:45:53 2026 GMT
smart support is: Available - device has SMART capability.
smart support is: Enabled
```

```
==== start of read smart data section ===
smart overall-health self-assessment test result: PASSED
```

```
general smart values:
offline data collection status:  (0x82)Offline data collection activity
was completed without error.
auto offline data collection: Enabled.
self-test execution status:      (  0)The previous self-test routine completed
without error or no self-test has ever
been run.
total time to complete offline
data collection: (  90) seconds.
offline data collection
capabilities:  (0x7b) SMART execute Offline immediate.
auto offline data collection on/off support.
suspend offline collection upon new
command.
offline surface scan supported.
self-test supported.
conveyance self-test supported.
selective self-test supported.
smart capabilities:           (0x0003)Saves SMART data before entering
power-saving mode.
supports smart auto save timer.
error logging capability:      (0x01)Error logging supported.
general purpose logging supported.
short self-test routine
recommended polling time: (  2) minutes.
extended self-test routine
recommended polling time: ( 484) minutes.
conveyance self-test routine
recommended polling time: (  3) minutes.
sct capabilities:            (0x50bd)SCT Status supported.
sct error recovery control supported.
sct feature control supported.
sct data table supported.
```

```
smart attributes data structure revision number: 10
vendor specific smart attributes with thresholds:
id# attribute_name      flag    value  worst thresh type    updated  when_failed raw_value
 1 raw_read_error_rate  0x010f   078    056    ---  pre-fail  always   -       66606039
 3 spin_up_time         0x0103   094    093    ---  pre-fail  always   -       0
 4 start_stop_count     0x0032   100    100    ---  old_age   always   -       28
```

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# Disk Erasure Report

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```

commands leading to the command that caused the error were:
cr fr sc sn cl ch dh dc      powered_up_time  command/feature_name
-----  -----
42 00 00 ff ff ff 4f 00 21d+21:41:18.492 READ VERIFY SECTOR(S) EXT
42 00 01 ff ff ff 4f 00 21d+21:41:18.276 READ VERIFY SECTOR(S) EXT
35 00 01 ff ff ff 4f 00 21d+21:41:18.275 WRITE DMA EXT
60 00 40 ff ff ff 4f 00 21d+21:41:18.257 READ FPDMA QUEUED
42 00 00 ff ff ff 4f 00 21d+21:41:10.619 READ VERIFY SECTOR(S) EXT

```

error 477 occurred at disk power-on lifetime: 7084 hours (295 days + 4 hours)  
when the command that caused the error occurred, the device was active or idle.

```
after command completion occurred, registers were:  
er st sc sn cl ch dh  
-- -- -- -- -- --  
40 51 00 ff ff ff 0f  error: UNC at LBA = 0xffffffff = 268435455
```

```

commands leading to the command that caused the error were:
cr fr sc sn cl ch dh dc    powered_up_time    command/feature_name
-----  -----
42 00 00 ff ff ff 4f 00  21d+21:41:18.492  READ VERIFY SECTOR(S) EXT
42 00 01 ff ff ff 4f 00  21d+21:41:18.276  READ VERIFY SECTOR(S) EXT
35 00 01 ff ff ff 4f 00  21d+21:41:18.275  WRITE DMA EXT
60 00 40 ff ff ff 4f 00  21d+21:41:18.257  READ FPDMA QUEUED
42 00 00 ff ff ff 4f 00  21d+21:41:10.619  READ VERIFY SECTOR(S) EXT

```

error 476 occurred at disk power-on lifetime: 7084 hours (295 days + 4 hours)  
when the command that caused the error occurred, the device was active or idle.

```
after command completion occurred, registers were:  
er st sc sn cl ch dh  
-- -- -- -- -- --  
40 51 00 ff ff ff 0f  error: UNC at LBA = 0xffffffff = 268435455
```

```

commands leading to the command that caused the error were:
cr fr sc sn cl ch dh dc    powered_up_time    command/feature_name
-----  -----
42 00 00 ff ff ff 4f 00  21d+21:41:10.619  READ VERIFY SECTOR(S) EXT
42 00 01 ff ff ff 4f 00  21d+21:41:10.523  READ VERIFY SECTOR(S) EXT
35 00 01 ff ff ff 4f 00  21d+21:41:10.523  WRITE DMA EXT
61 00 08 ff ff ff 4f 00  21d+21:41:10.471  WRITE FPDMA QUEUED
61 00 08 ff ff ff 4f 00  21d+21:41:10.471  WRITE FPDMA QUEUED

```

error 475 occurred at disk power-on lifetime: 7084 hours (295 days + 4 hours)  
when the command that caused the error occurred, the device was active or idle.

```
after command completion occurred, registers were:  
er st sc sn cl ch dh  
-- -- -- -- -- --  
40 51 00 ff ff ff 0f  error: UNC at LBA = 0xffffffff = 268435455
```

commands leading to the command that caused the error were:									
cr	fr	sc	sn	cl	ch	dh	dc	powered_up_time	command/feature_name
42	00	00	ff	ff	ff	4f	00	21d+21:41:10.619	READ VERIFY SECTOR(S) EXT
42	00	01	ff	ff	ff	4f	00	21d+21:41:10.523	READ VERIFY SECTOR(S) EXT
35	00	01	ff	ff	ff	4f	00	21d+21:41:10.523	WRITE DMA EXT
61	00	08	ff	ff	ff	4f	00	21d+21:41:10.471	WRITE FPDMA QUEUED
61	00	08	ff	ff	ff	4f	00	21d+21:41:10.471	WRITE FPDMA QUEUED

```
smart self-test log structure revision number 1
num test_description      status          remaining  lifetime(hours)  lba_of_first_error
# 1 short offline        completed without error  00%          3          -
# 2 vendor (0xdf)        completed without error  00%          3          -
```



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## Disk Erasure Report

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```
smart selective self-test log data structure revision number 1
span  min_lba  max_lba  current_test_status
 1      0        0  not_testing
 2      0        0  not_testing
 3      0        0  not_testing
 4      0        0  not_testing
 5      0        0  not_testing
selective self-test flags (0x0):
  after scanning selected spans, do not read-scan remainder of disk.
  if selective self-test is pending on power-up, resume after 0 minute delay.
```